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U.S. Department of Commerce Patent and Trademark Office

Attomey's Docket No. 05918-117001

Application No. 09/808,395

on Disclosure Statement

by Applicant several sheets if necessary)

K. Theodor Krantz et al.

Filing Date

**Applicant** 

March 14, 2001

Group Art Unit 1771

Exe **U.S. Patent Documents** Desig. Examiner Document **Publication** Filing Date Initial ID Number Date **Patentee** Class Subclass If Appropriate

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